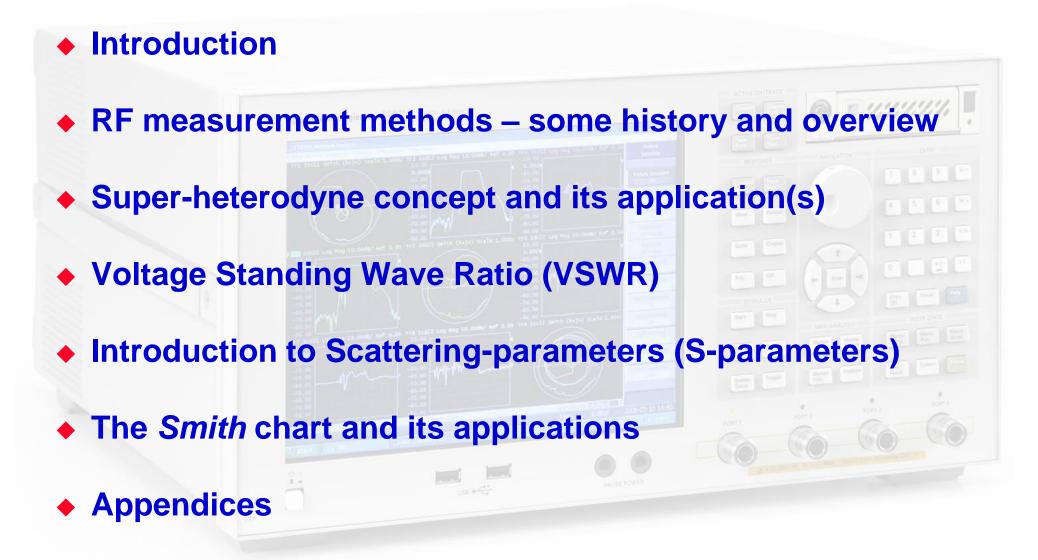
RF Measurement Concepts

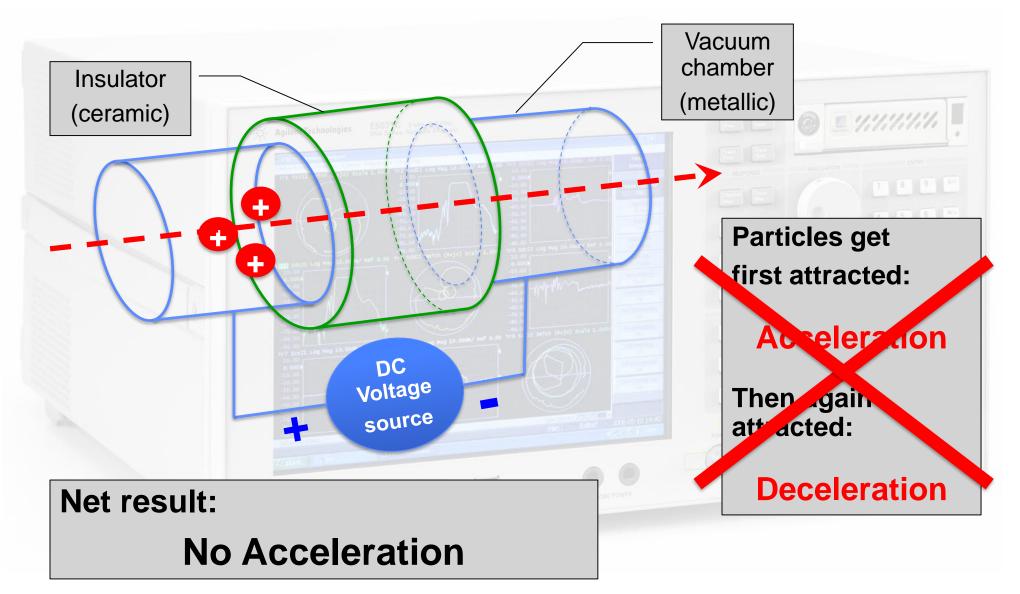
Piotr Kowina, Christine Völlinger, Manfred Wendt Accelerator Physics (advanced level) Egham, UK, 4 – 14 September 2017

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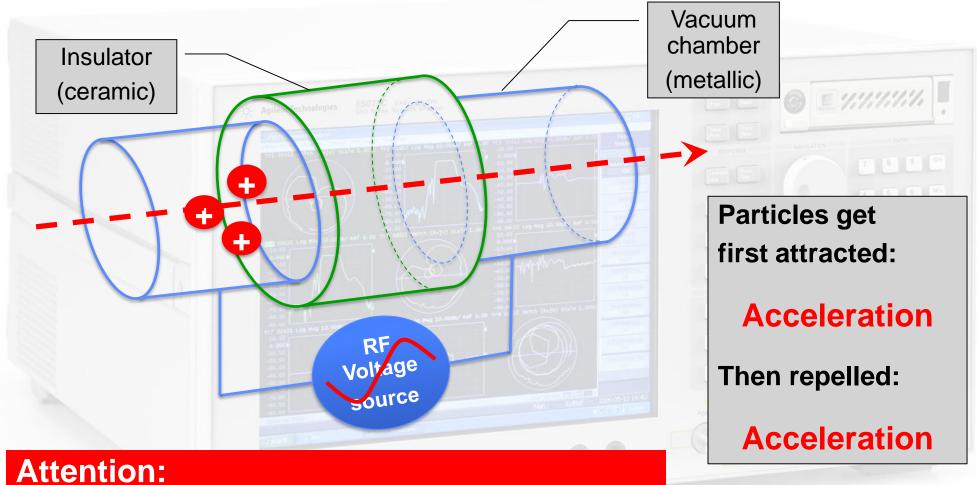
Contents



Introduction – DC Acceleration

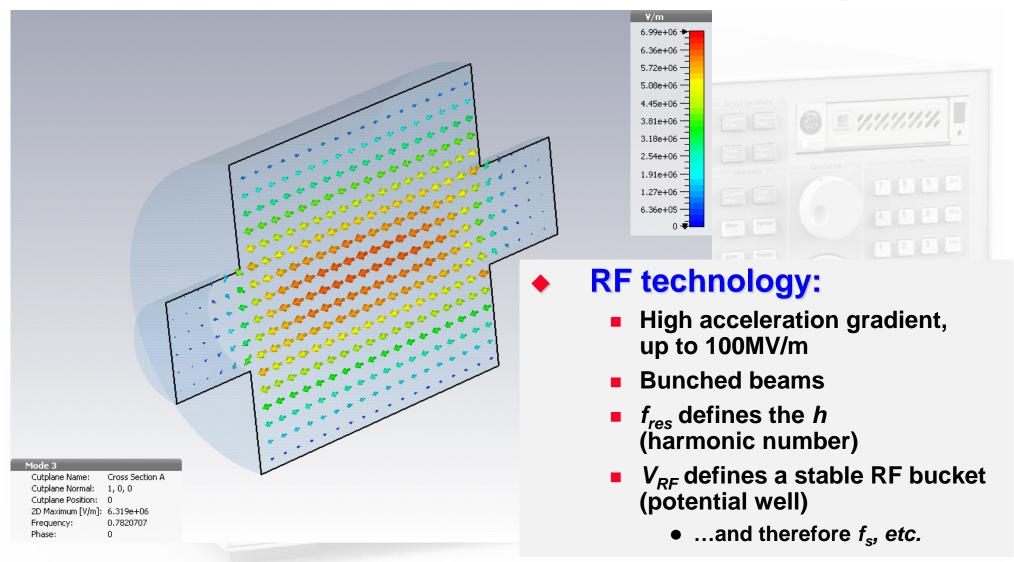


Introduction – RF Acceleration

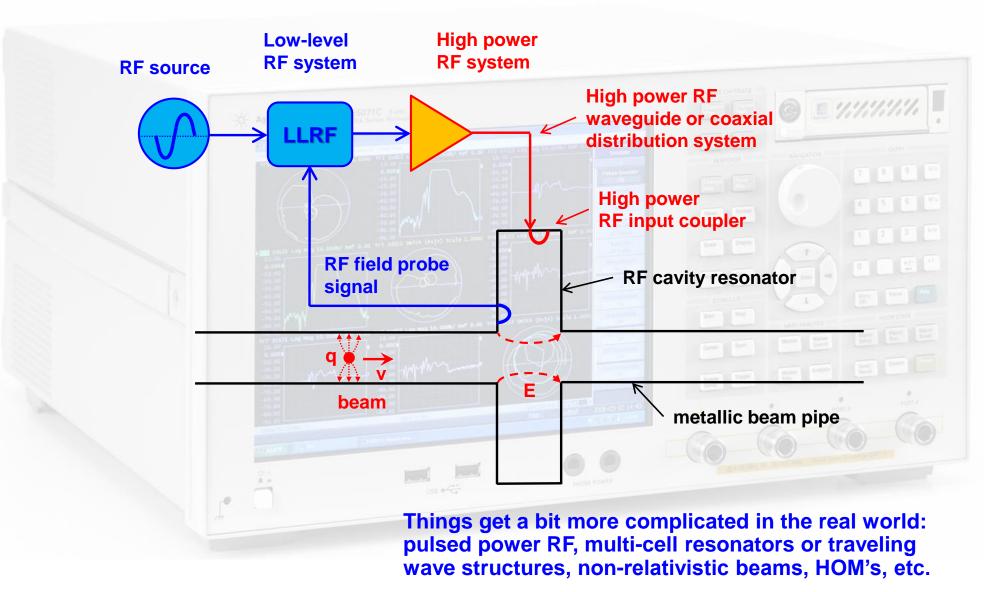


It is almost never a good idea to locate an unshielded ceramic gap in a beam pipe!

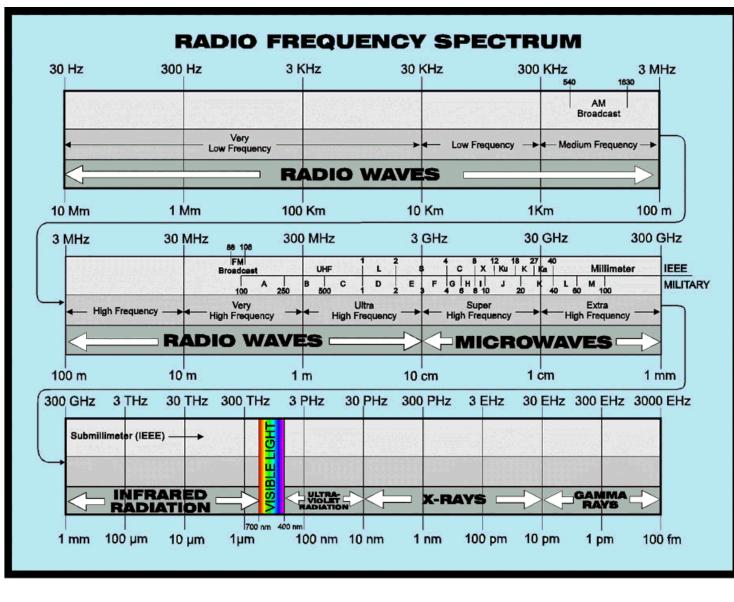
Introduction – Resonant Cavity



Introduction – Simple RF System



Introduction – What are Radio Frequencies?



 $\lambda = \frac{c}{f}$ We care about RF concepts if the physical dimensions of an apparatus is > $\lambda/10$

Free space

wavelength:

RF Measurements Methods (1)

There are many ways to observe RF signals. Here some typical tools:

- Oscilloscope: to observe signals in time domain
 - periodic signals
 - burst and transient signals with arbitrary waveforms
 - application: direct observation of signals from a beam pick-up, test generator and other sources, shape of a waveform, evaluation of non-linear effects, etc.

Spectrum analyzer: to observe signals in frequency domain

- sweeps in equidistant steps through a given frequency range
- application: observation of spectrum from the beam, or from a signal generator or RF source, or the spectrum emitted from an antenna to locate EMI issues in the accelerator tunnel, etc.
- Requires periodic signals

E 1,1,1,1,1,

RF Measurements Methods (2)

Dynamic signal analyzer (FFT analyzer)

- Acquires the signal, often after down-conversion, in time domain by fast sampling
- Further numerical treatment in digital signal processors (DSPs)
- Spectrum calculated using Fast Fourier Transform (FFT)
- Combines features of an oscilloscope and a spectrum analyzer: Signals can be observed directly in time or in frequency domain
- Contrary to the SA, also the spectrum of non-periodic signals and transients can be measured
- Application: Observation of tune sidebands, transient behavior of a phase locked loop, single pass beam signal spectrum, etc.
- Digital oscilloscopes and FFT analyzers share similar technologies, i.e. fast sampling and digital signal processing, and therefore can provide similar measurement options

RF Measurements Methods (2)

Tools to characterize RF components and sub-systems:

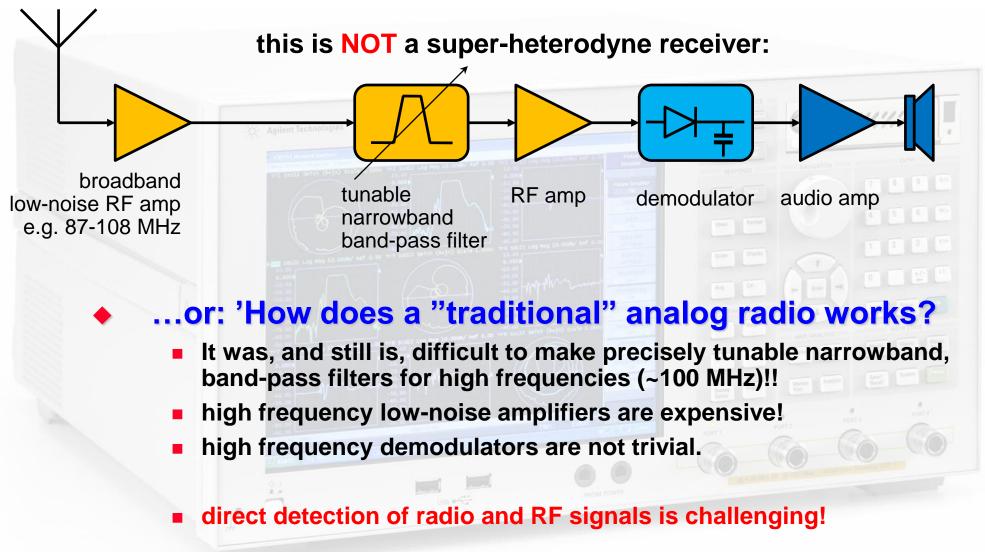
Coaxial (or waveguide) measurement transmission-line

 For study and illustration purposes only – not anymore used in today's RF laboratory environment.

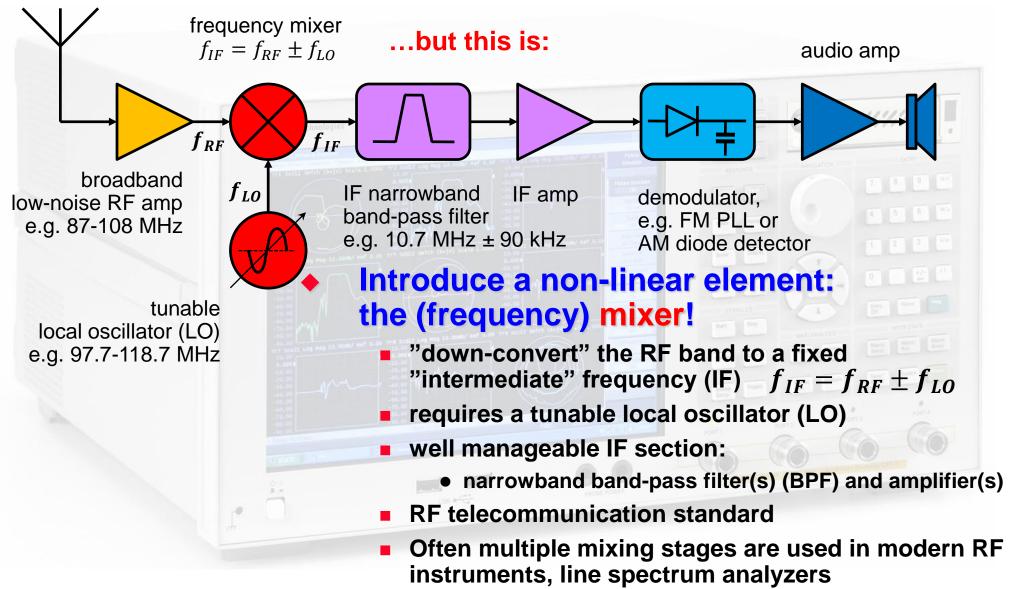
Vector Network Analyzer (VNA)

- Excites a Device Under Test (DUT, e.g. circuit, antenna, amplifier, etc.) network at a given Continuous Wave (CW) frequency, and measures the response in magnitude and phase => determines the S-parameters
 - What are S-parameters?!
- Covers a selectable frequency range by measuring step-by-step at subsequent frequency points (similar to the spectrum analyzer)
- Applications: characterization of passive and active RF components, *Time Domain Reflectometry* (TDR) by Fourier transformation of the reflection response, etc.
- The VNA is the most versatile and comprehensive tool in the RF laboratory

The Super-Heterodyne Receiver (1)

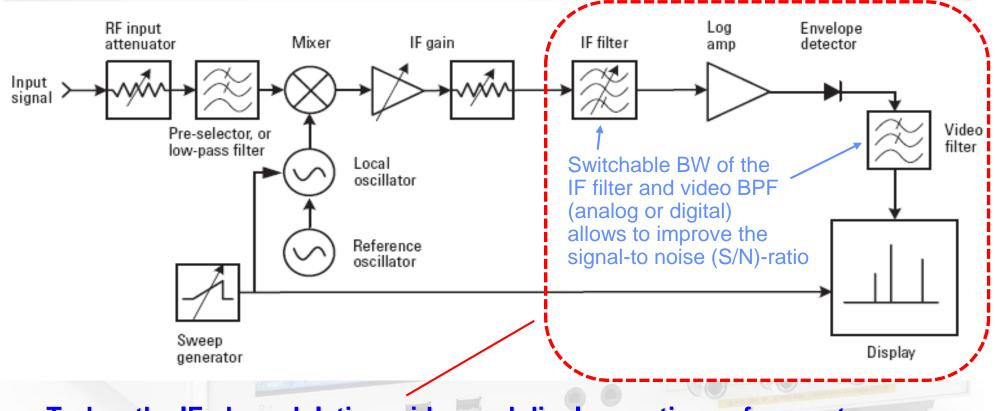


The Super-Heterodyne Receiver (2)



Simplified Spectrum Analyzer

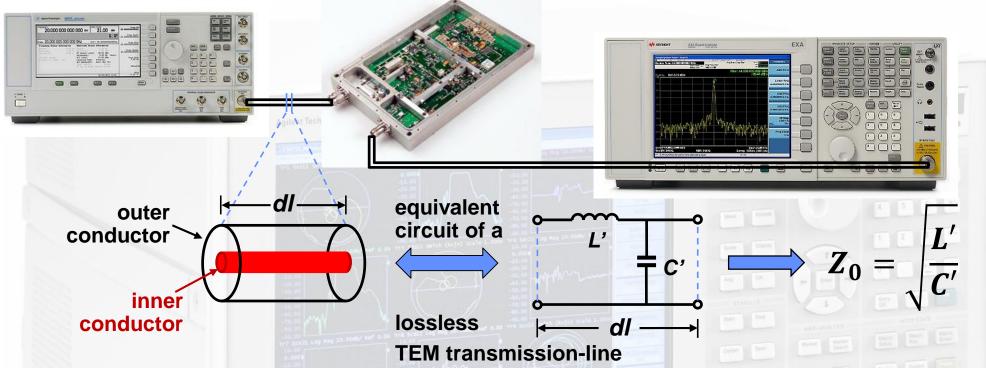
based on the super-heterodyne principle



Today, the IF, demodulation, video and display sections of a spectrum analyzer are realized digitally

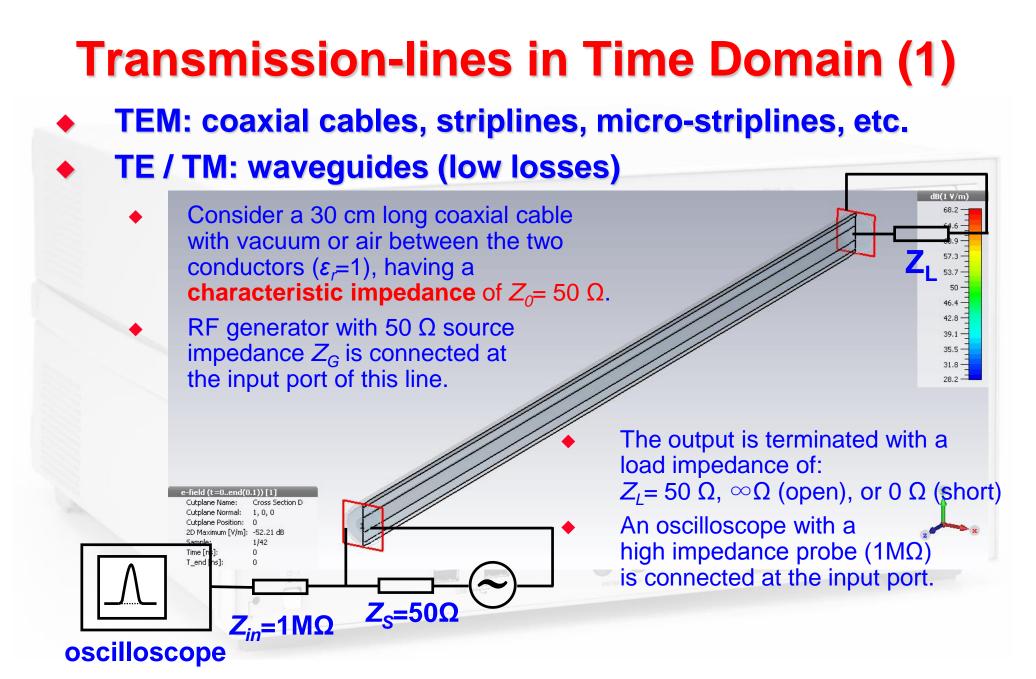
Requires an analog-digital converter (ADC) with sufficient dynamic range

Characteristic Impedance

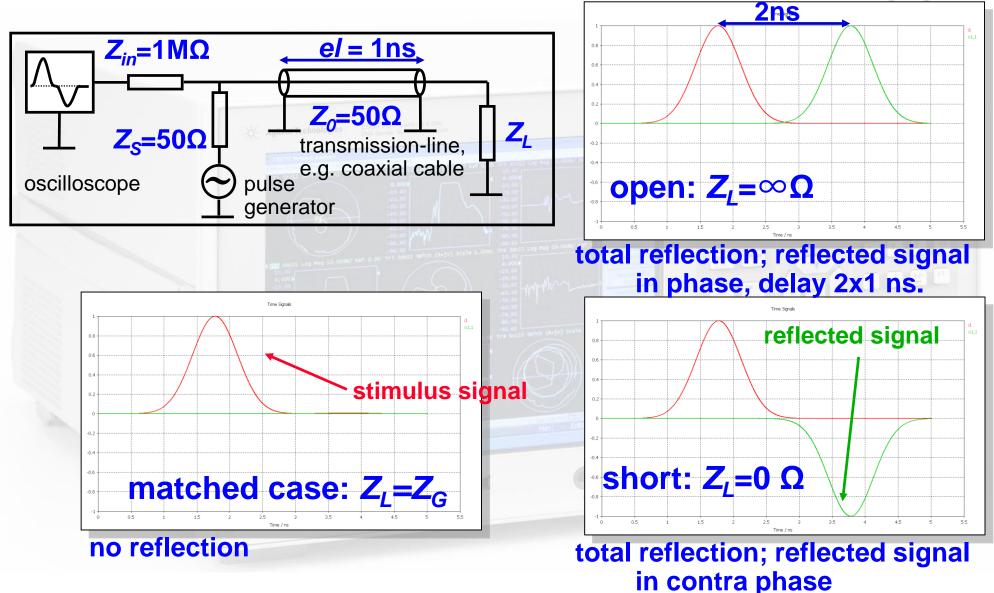


The reference impedance Z_{ρ} in a RF system is defined by the characteristic impedance of the interconnect cables

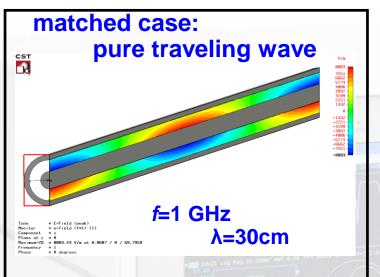
- often coaxial cables of Z_0 =50 Ω (compromise: high voltage / high power handling)
- The characteristic impedance of a TEM transmission-line is defined by the cross-section geometry
 - Ratio of H- and E-field, represented by L' [H/m] and C' [F/m] in the equivalent circuit of a line segment dl
 - The characteristic impedance Z₀ has the unit Ohm [Ω]



Transmission-lines in Time Domain (2)

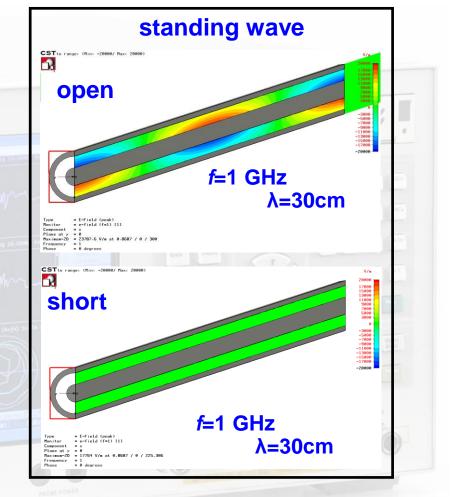


Transmission-lines in Frequency Domain



Standing and traveling waves:

- The patterns for the short and open case are equal; only the phase is opposite, which correspond to different position of nodes.
- In case of perfect matching:
 - traveling wave only.
- Otherwise:
 - mixture of traveling and standing waves.



Caution: the color coding corresponds to the radial electric field strength – these are not scalar equipotential lines, which are anyway not defined for time varying fields

Voltage Standing Wave Ratio VSWR (1)

- On a transmission-line (single frequency, CW):
 - Superposition of forward a (E^{inc}) and backward b (E^{refl}) traveling waves
 standing waves
 - Slotted coaxial air-line is used as standing wave detector
 - Probes the radial electric field along the slotted line.
 - Measurement of E-field minima's E_{min} and maxima's E_{max} with a diode detector, thus detect $|V_{min}|$ and $|V_{max}|$ along the line.

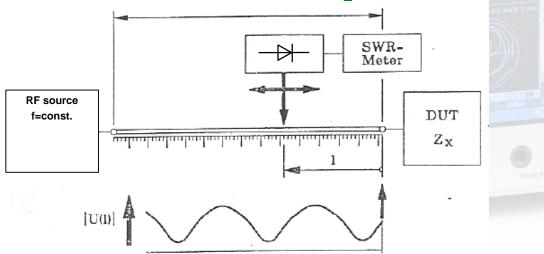
Erefl

Einc

 $Z_L - Z_0$

 $Z_L + Z_0$

Evaluate the reflection coefficient Γ of a DUT of unknown Z_L at the end of the line



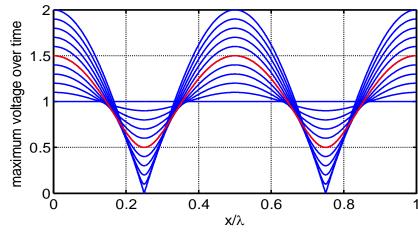
Voltage Standing Wave Ratio VSWR (2)

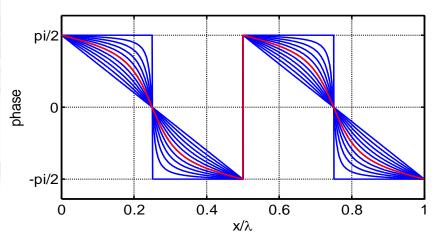
The VSWR is defined as:

 $VSWR = \frac{|V_{max}|}{|V_{min}|} = \frac{|a| + |b|}{|a| - |b|} = \frac{1 + |\Gamma|}{1 - |\Gamma|}$

- The phase of the detected E-field along the lossless coaxial line is purged by the diode detection.
 - Requires a mixer as detector!

Г	Return Loss [dB]	$VSWR = Z_L/Z_0$	Refl. Power 1-/Γ/ ²
0.0	œ	1.00	1.00
0.1	20	1.22	0.99
0.2	14	1.50	0.96
0.3	10	1.87	0.91
0.4	8	2.33	0.84
0.5	6	3.00	0.75
0.6	4	4.00	0.64
0.7	3	5.67	0.51
0.8	2	9.00	0.36
0.9	1	19	0.19
1.0	0	00	0.00





S-Parameters – Introduction (1)

Light falling on a car window:

- Some parts of the incident light is reflected (you see the mirror image)
- Another part of the light is transmitted through the window (you can still see inside the car)
- Optical reflection and transmission coefficients of the window glass define the ratio of reflected and transmitted light

Similar: Scattering (S-) parameters of an *n*-port electrical network (DUT) characterize reflected and transmitted (power) waves





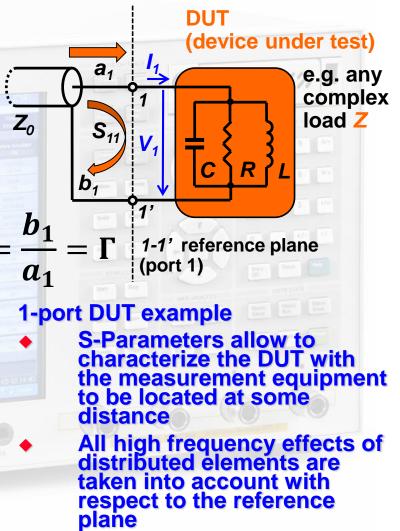
S-Parameters – Introduction (2)

Electrical networks

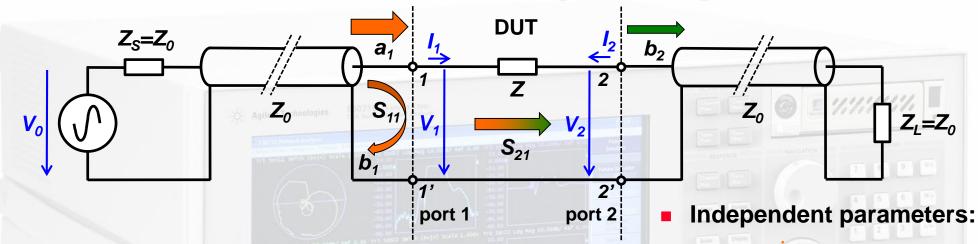
- 1...n-ports circuits
- Defined by voltages $V_n(\omega)$ or $v_n(t)$ and currents $I_n(\omega)$ or $i_n(t)$ at the ports
- Characterized by circuit matrices, e.g. ABCD, Z, Y, H, etc.

RF networks

- 1...n-port RF DUT circuit or subsystem, e.g. filter, amplifier, transmission-line, hybrid, circulator, resonator, etc.
- Defined by incident a_n(ω, s) and reflected waves b_n(ω, s) at a reference plane s (physical position) at the ports
- Characterized by a scattering parameter (S-parameter) matrix of the reflected and transmitted power waves
- Normalized to a reference impedance $\sqrt{Z_0}$ of typically $Z_0 = 50 \Omega$



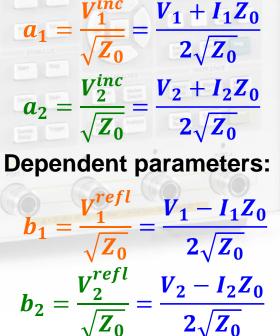
S-Parameters – Example: 2-port DUT



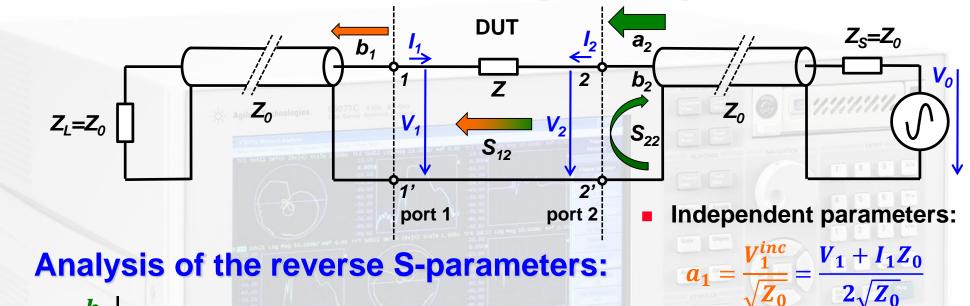
Analysis of the forward S-parameters:

- $S_{11} = \frac{b_1}{a_1}\Big|_{a_2=0} \equiv \text{input reflection coefficient} \\ S_{21} = \frac{b_2}{a_1}\Big|_{a_2=0} \equiv \text{forward transmission gain}$

 - Examples of 2-ports DUT: filters, amplifiers, attenuators, transmission-lines (cables), etc.
 - ALL ports ALWAYS need to be terminated in their characteristic impedance!



S-Parameters – Example: 2-port DUT

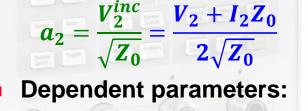


Analysis of the reverse S-parameters:

- $S_{22} = \frac{b_2}{a_2}\Big|_{a_1=0} \equiv \text{output reflection coefficient} \\ (Z_L = Z_0 \Rightarrow a_1 = 0) \\ S_{12} = \frac{b_1}{a_2}\Big|_{a_1=0} \equiv \text{backward transmission gain}$

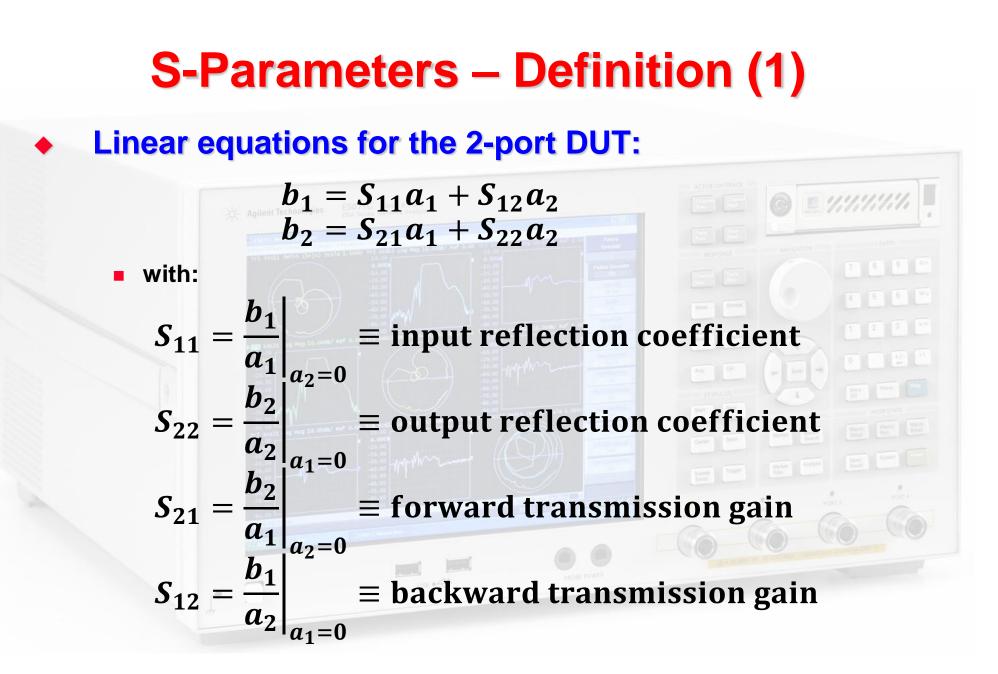
n-port DUTs still can be fully characterized with a 2-port VNA, but again: don't forget to terminate unused ports!

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 $b_2 = \frac{V_2^{refl}}{\sqrt{Z_0}} = \frac{V_2 - I_2 Z_0}{2 \sqrt{Z_0}}$

 $\frac{V_1^{reft}}{\sqrt{Z_0}} = \frac{V_1 - I_1 Z_0}{2\sqrt{Z_0}}$



S-Parameters – Definition (2)

Reflection coefficient and impedance at the *n*th**-port of a DUT:**

$$S_{nn} = \frac{b_n}{a_n} = \frac{\frac{V_n}{I_n} - Z_0}{\frac{V_n}{I_n} + Z_0} = \frac{Z_n - Z_0}{Z_n + Z_0} = \Gamma_n$$

$$Z_n = Z_0 \frac{1 + S_{nn}}{1 - S_{nn}} \text{ with } Z_n = \frac{V_n}{I_n} \text{ being the input impedance at the } n^{th} \text{ port}$$
Bever reflection and transmission for a p-port DUT

ower reflection and transmission for a *n*-port i

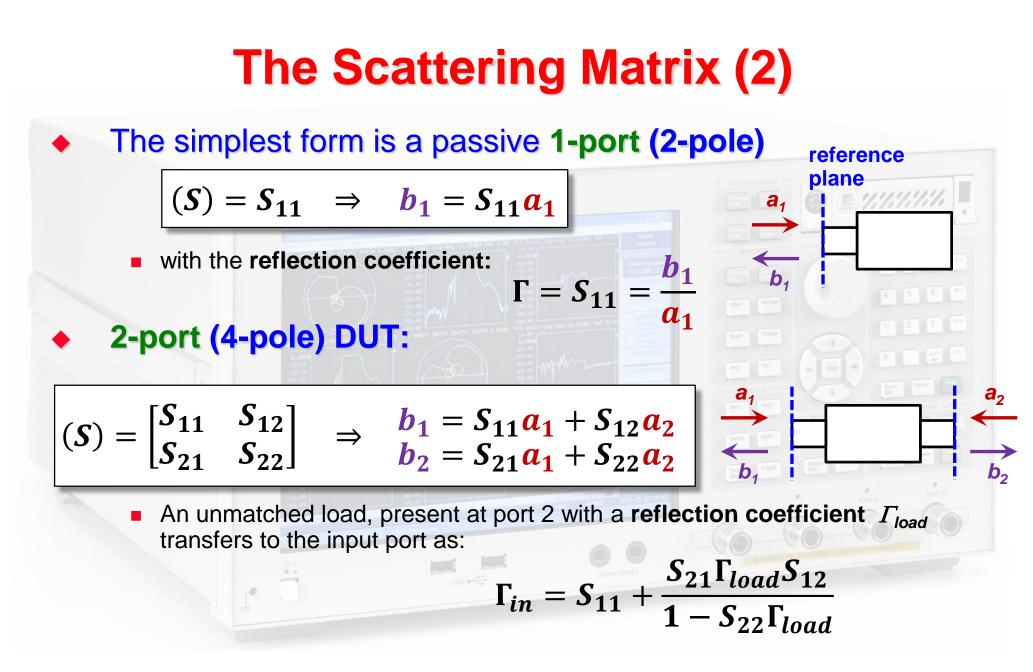
 $|S_{nn}|^2 = \frac{\text{power reflected from port } n}{\text{power incident on port } n}$

 $|S_{nm}|^2$ = transmitted power between ports *n* and *m*

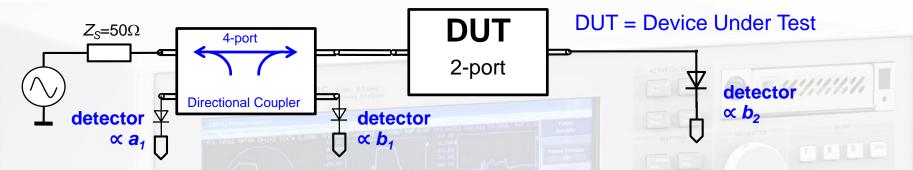
with all ports terminated in their characteristic impedance Z_0 and $Z_S = Z_0$ Here the US notion is used, where power = $|a|^2$. European notation (often): power = $|a|^2/2$ These conventions have no impact on the S-parameters, they are only relevant for absolute power calculations

The Scattering Matrix (1)

Waves traveling towards the *n*-port: $(a) = (a_1, a_2, a_2, \dots, a_n)$ Waves traveling away from the *n*-port: $(b) = (b_1, b_2, b_2, \dots, b_n)$ The relation between a_i and b_i (i = 1..n) can be written as a system of n linear equations $(a_i = \text{the independent variable}, b_i = \text{the dependent variable})$ $b_1 = S_{11}a_1 + S_{12}a_2 + S_{13}a_3 + S_{14}a_4 + \dots$ one-port $b_2 = S_{21}a_1 + S_{22}a_2 + S_{23}a_3 + S_{44}a_4 + \dots$ two-port $b_3 = S_{31}a_1 + S_{32}a_2 + S_{33}a_3 + S_{44}a_4 + \dots$ three - port $b_4 = S_{41}a_1 + S_{42}a_2 + S_{33}a_3 + S_{44}a_4 + \dots$ four - port in compact matrix form follows (b) = (S)(a)



How to measure S-Parameters?

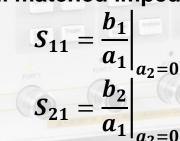


Performed in the frequency domain

- Single or swept frequency generator, stand-alone or as part of a VNA or SA
- Requires a directional coupler and RF detector(s) or receiver(s)

Evaluate S₁₁ and S₂₁ of a 2-port DUT

- Ensure $a_2=0$, i.e. the detector at port 2 offers a well matched impedance
- Measure incident wave a1 and reflected wave b1 at the directional coupler ports and compute for each frequency
- Measure transmitted wave b₂ at DUT port 2 and compute



- Evaluate S₂₂ and S₁₂ of the 2-port DUT
 - Perform the same methodology as above by exchanging the measurement equipment on the DUT ports

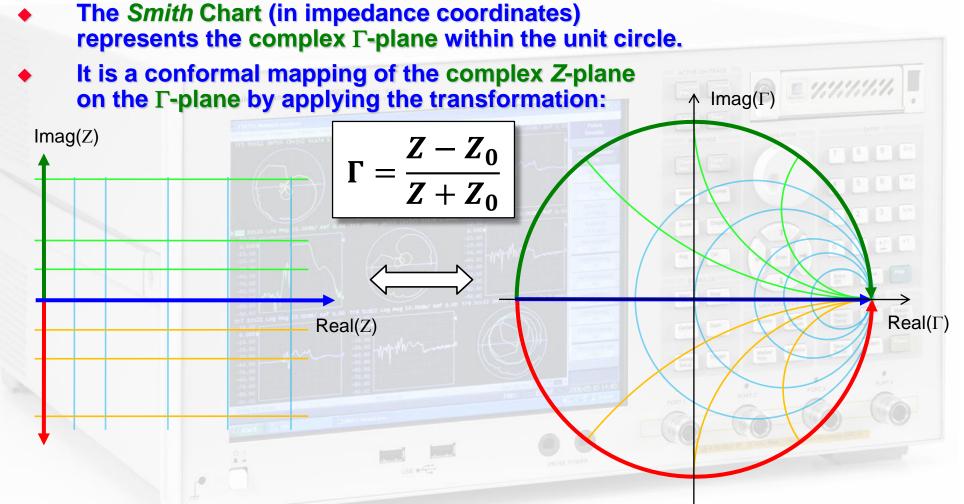
S-Parameters – Summary

- Scattering parameters (S-parameters) characterize an RF component or system (DUT) by a matrix.
 - nxn matrix for n-port device
 - Based on incident (a_n) and reflected (b_n) power waves

ALL ports need to be terminated in their characteristic (reference) impedance Z_0

- For a proper S-parameter measurement or numerical computation all ports of the Device Under Test (DUT), including the generator port, must be terminated with their characteristic impedance to assure, waves traveling away from the DUT (b_n-waves) are not reflected twice or multiple times, and convert into a_n-waves. (cannot be stated often enough...!)
- Typically S-parameters and DUT characteristics are "measured" and characterized in the frequency domain
 - S-parameters, as wells as DUT circuit elements are described in complex notation with the frequency variable $\omega = 2\pi f$
 - Frequency transformation (iDFT) allows time domain measurements with a "modern" vector network analyzer (VNA).

The Smith Chart (1)



■ ⇒ the real positive half plane of Z is thus transformed (*Möbius*) into the interior of the unit circle!

The Smith Chart (2)

The Impedance Z is usually normalized

ZΩ to a reference impedance Z_0 , typically the characteristic impedance of the coaxial cables of $Z_0=50\Omega$.

Z =

The normalized form of the transformation follows then as:

$$\Gamma = rac{z-1}{z+1}$$
 resp. $rac{Z}{Z_0} = z = rac{1+\Gamma}{1-\Gamma}$

This mapping offers several practical advantages:

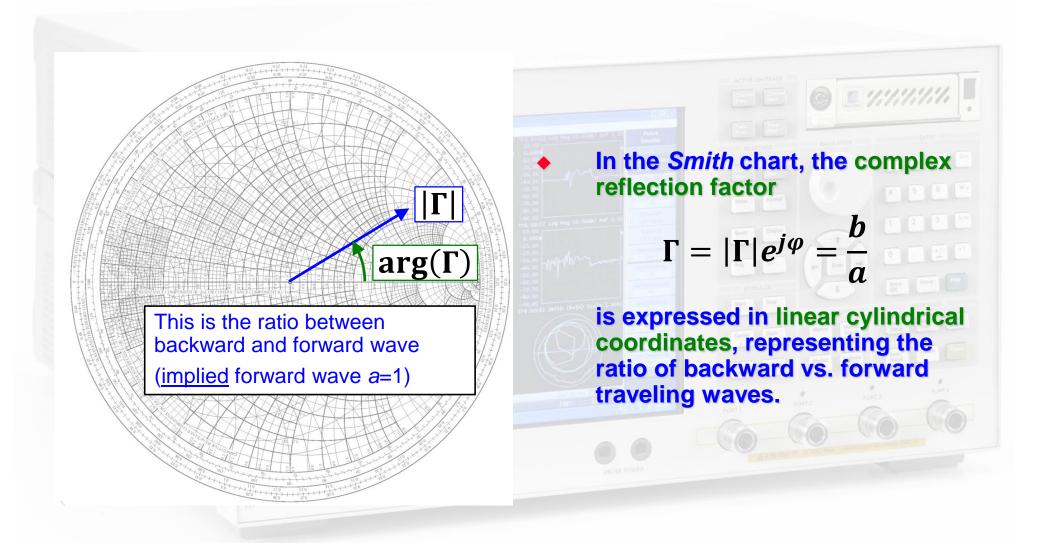
The diagram includes all "passive" impedances, i.e. those with positive real part, from zero to infinity in a handy format.

Impedances with negative real part ("active device", e.g. reflection amplifiers) would be outside the (normal) Smith chart.

The mapping converts impedances or admittances into reflection factors and vice-versa. This is particularly interesting for studies in the radiofrequency and microwave domain where electrical quantities are usually expressed in terms of "incident" or "forward", and "reflected" or "backward" waves.

- This replaces the notation in terms of currents and voltages used at lower frequencies.
- Also the reference plane can be moved very easily using the *Smith* chart.

The Smith Chart (3)

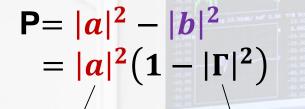


The Smith Chart (4)

- The distance from the center of the directly proportional to the magnitude of the reflection factor |Γ|, and permits an easy visualization of the matching performance.
 - In particular, the perimeter of the diagram represents total reflection: |Γ|=1.
 - (power dissipated in the load) =
 (forward power) (reflected power)

mismatch

losses



available source power

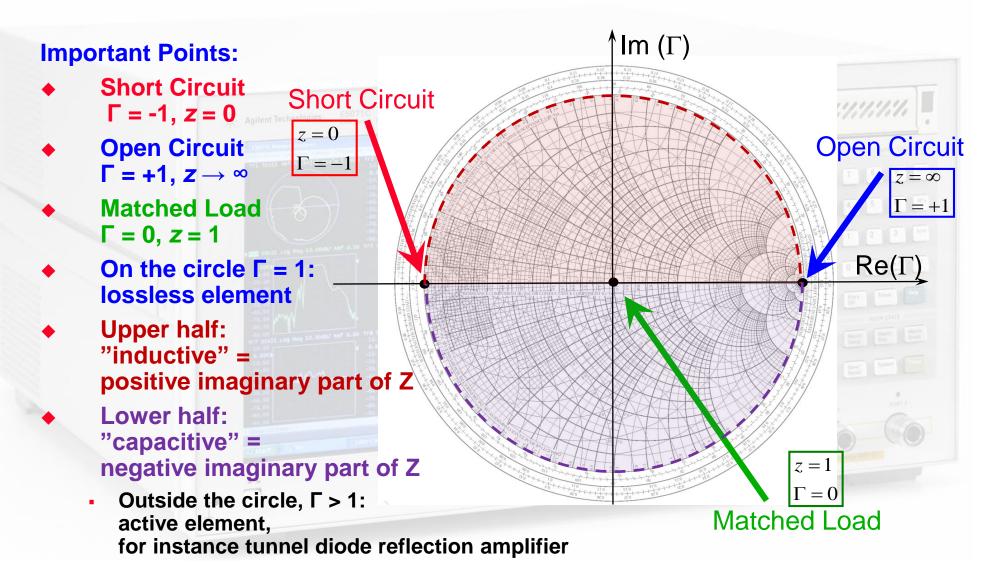
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 $=0.7^{-5}$

 $\Gamma = 0.5$

 $|\Gamma| = 0.25$

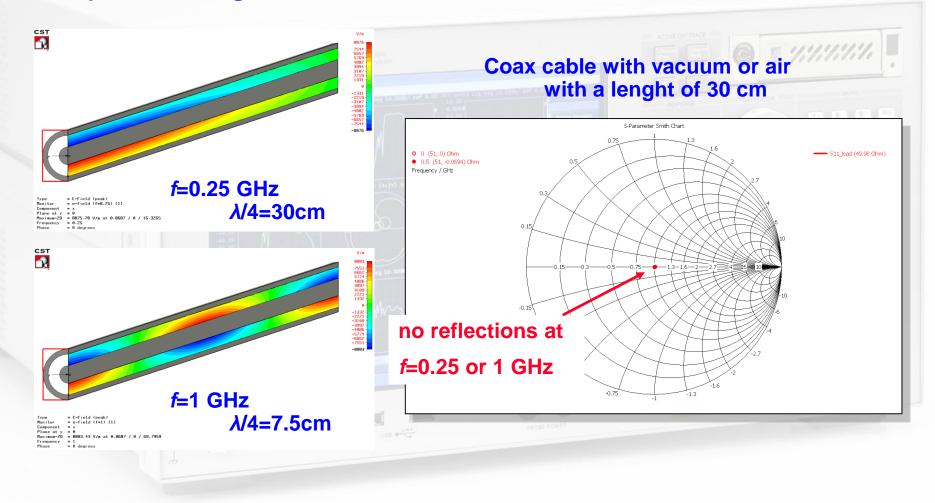
The Smith Chart – "Important Points"

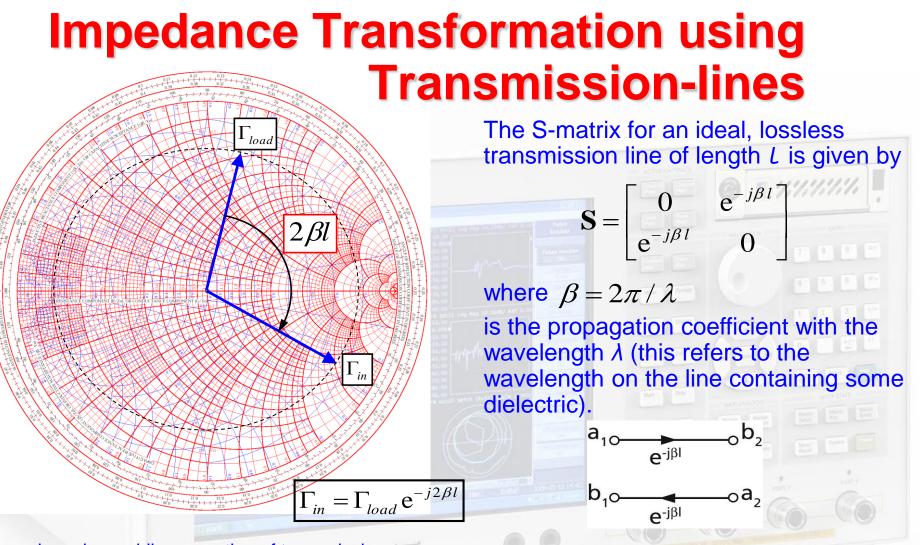


Coming back to our Example...

matched case:

pure traveling wave=> no reflection

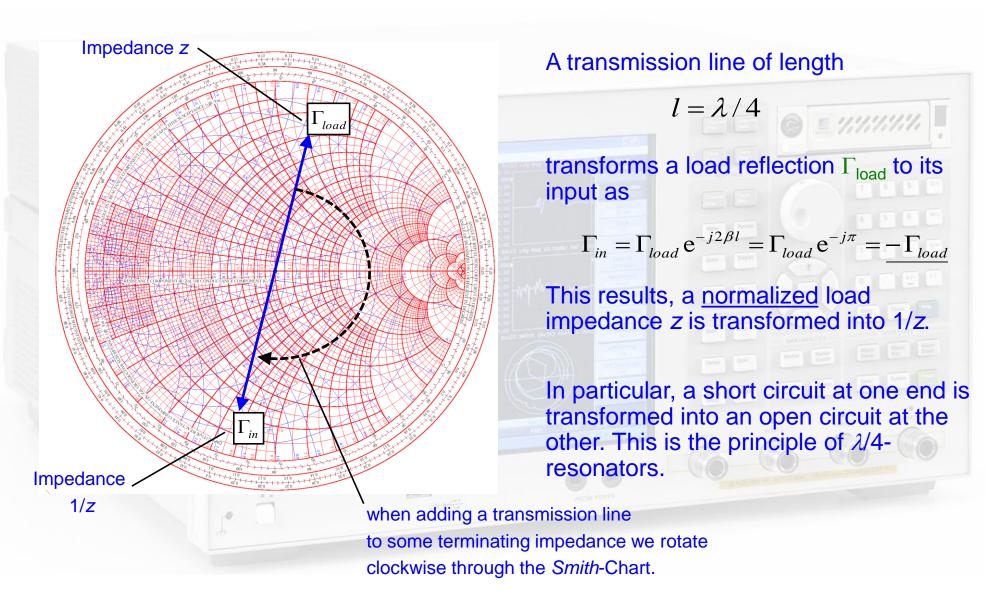




How to remember when adding a section of transmission line, we have to turn clockwise: assume we are at Γ = -1 (short circuit) and add a short piece of e.g. coaxial cable. We actually introduced an inductance, thus we are in the upper half of the *Smith*-Chart.

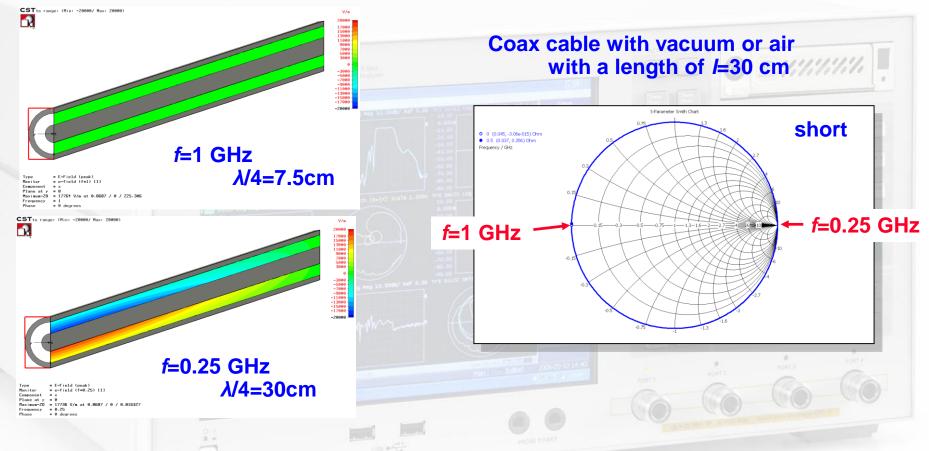
N.B.: The reflection factors are evaluated with respect to the characteristic impedance Z_0 of the line segment.

λ/4-line Transformations



Again our Example: Short at the end

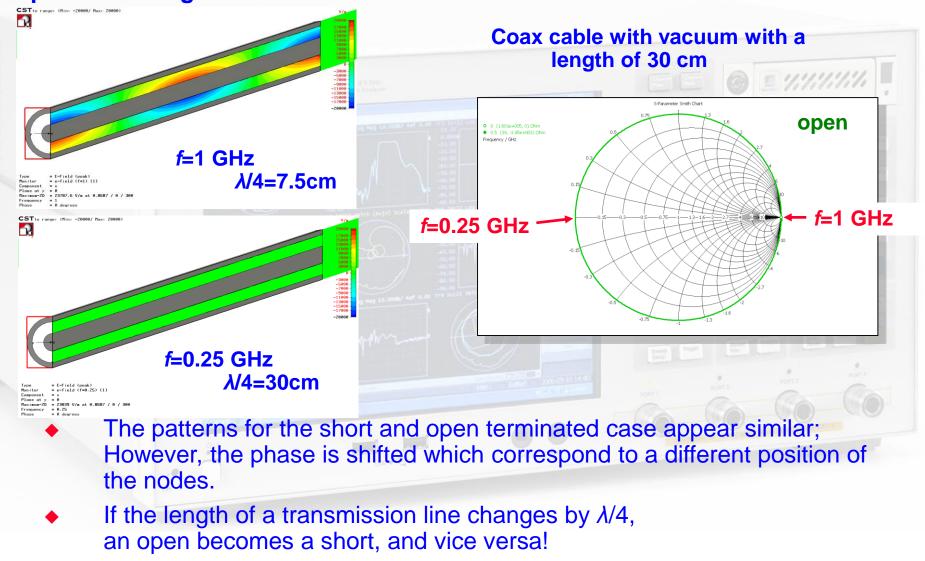
short : standing wave



If length of the transmission line changes by $\lambda/4$ a short circuit at one side is transformed into an open circuit at the other side.

Again our Example: Open end

open : standing wave



More Examples: See Appendix

The CERN Accelerator School

Transmission-line of Z=50 Ω , length l= $\lambda/4$

$$(S) = \begin{bmatrix} 0 & -j \\ -j & 0 \end{bmatrix} \qquad b_1 = -ja_2$$
$$b_2 = -ja_1$$

Attenuator 3dB, i.e. half output power

$$(S) = \frac{1}{\sqrt{2}} \begin{bmatrix} 0 & 1\\ 1 & 0 \end{bmatrix}$$

3-port circulator

CAS.

$$(S) = \begin{bmatrix} 0 & 0 & 1 \\ 1 & 0 & 0 \\ 0 & 1 & 0 \end{bmatrix}$$

$$b_1 = \frac{1}{\sqrt{2}} a_2 = 0.707 a_2$$
$$b_2 = \frac{1}{\sqrt{2}} a_1 = 0.707 a_1$$

 $b_1 = a_3$

 $b_2 = a_1$

 $b_3 = a_2$

What awaits you?

Hands-on RF and microwave lab experiments!

- 1 ton(!) of RF hardware shipped to RHUL
- From "vintage" surplus to the latest, greatest state-of-the-art RF measurement equipment!
- 6 test stands for 6 groups, each 3-4 students
 - 3x VNA, 3x SA & oscilloscope, plus slotted waveguide transmission-line
 - Plus: numerical simulations in the computer lab (CST Studio, QUCS)

Learning by doing!

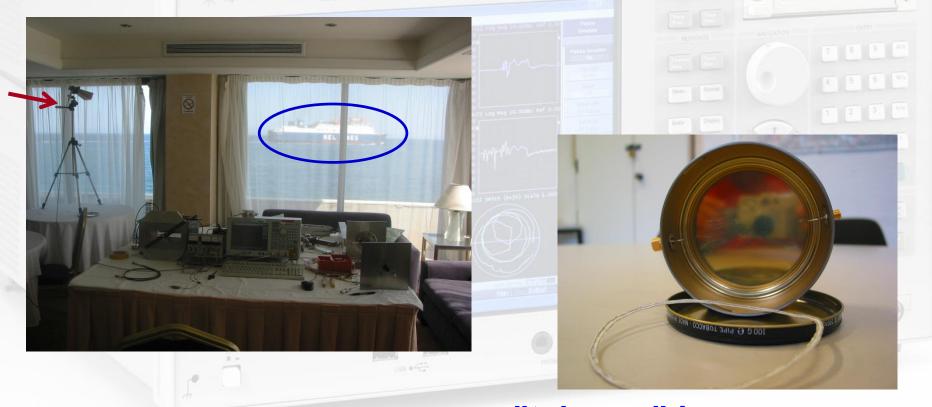




Invent your own Experiment!

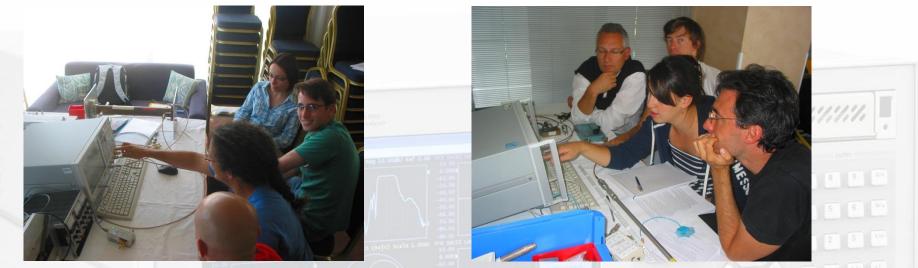
Build e.g. a Doppler traffic radar

Example from the CAS2011 RFlab, CHIOS. It really worked!

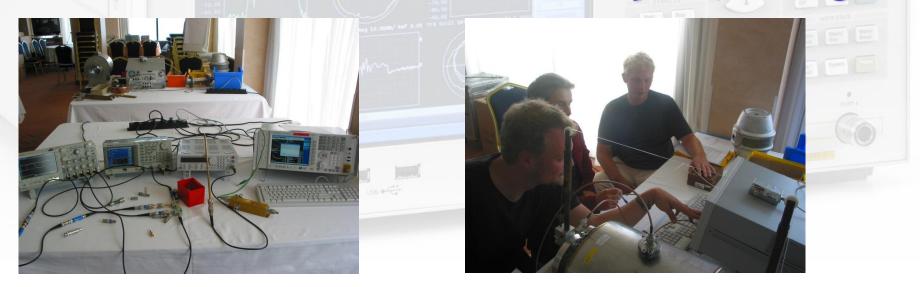


...or a "tobacco"-box resonator

You will have enough time to think...



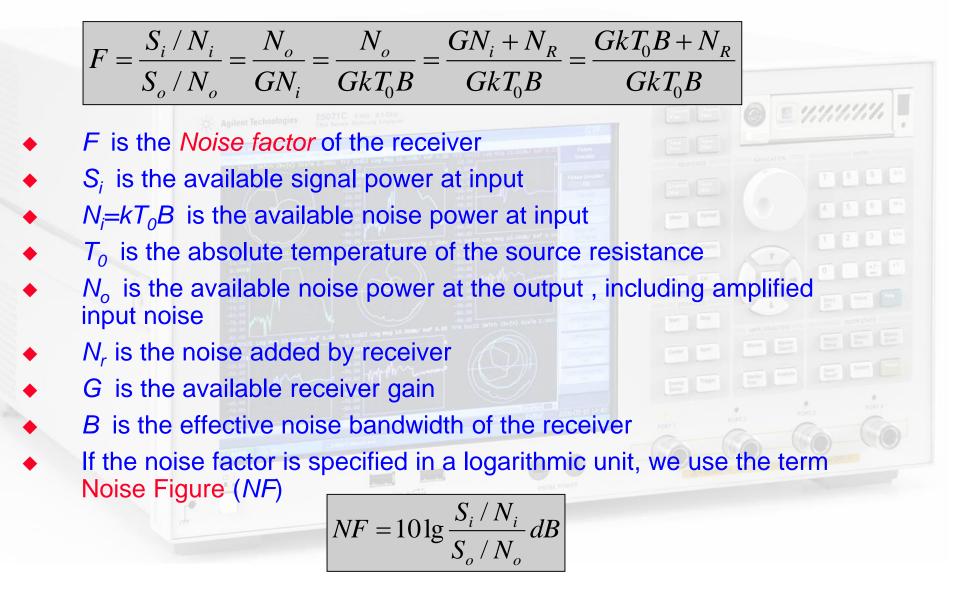
...and have contact with hardware and your colleagues



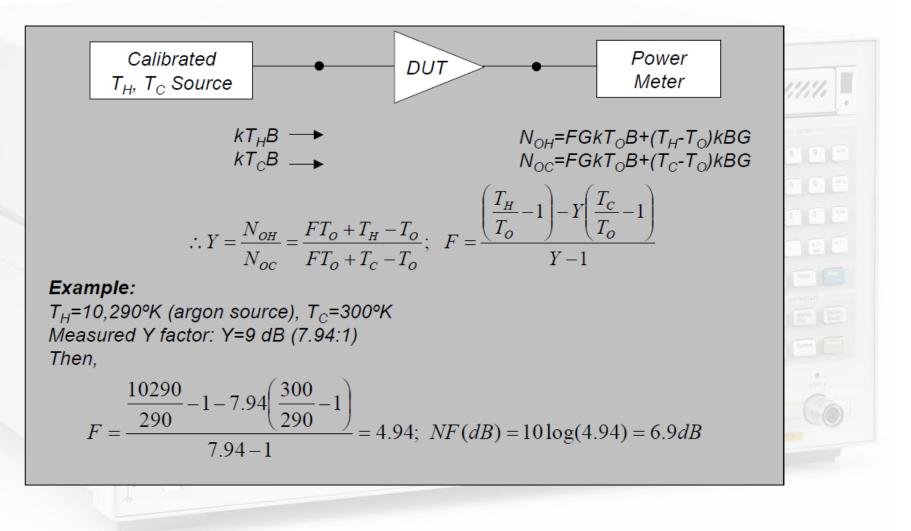
We hope you will have a lot of fun...!



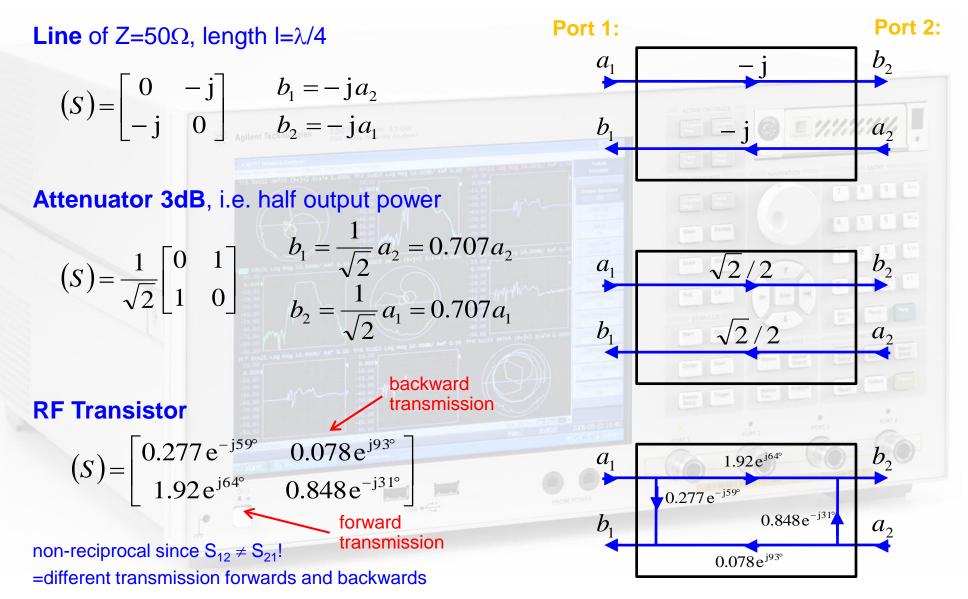
Appendix A: Definition of the Noise Figure



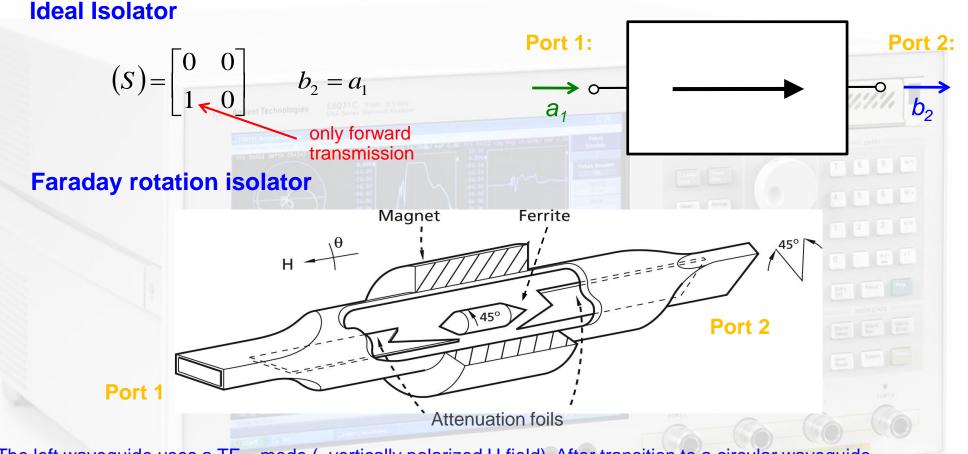
Measurement of Noise Figure (using a calibrated Noise Source)



Appendix B: Examples of 2-ports (1)

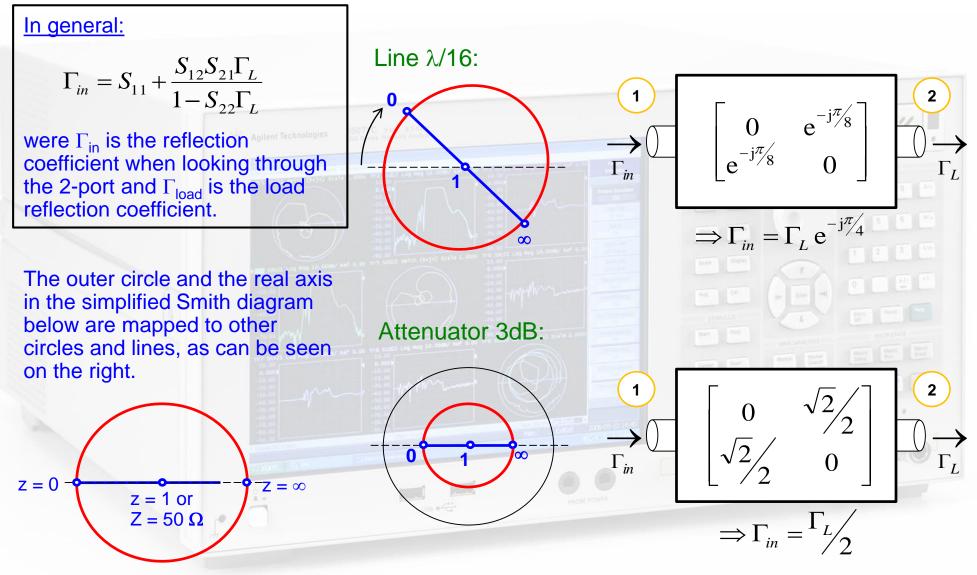


Examples of 2-ports (2)

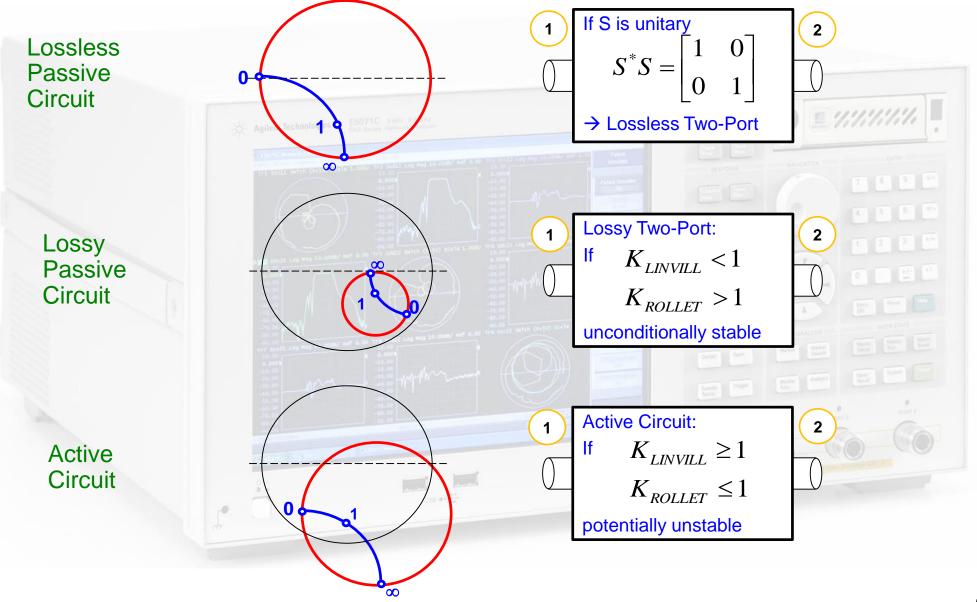


The left waveguide uses a TE₁₀ mode (=vertically polarized H field). After transition to a circular waveguide, the polarization of the mode is rotated counter clockwise by 45° by a ferrite. Then follows a transition to another rectangular waveguide which is rotated by 45° such that the forward wave can pass unhindered. However, a wave coming from the other side will have its polarization rotated by 45° clockwise as seen from the right hand side.

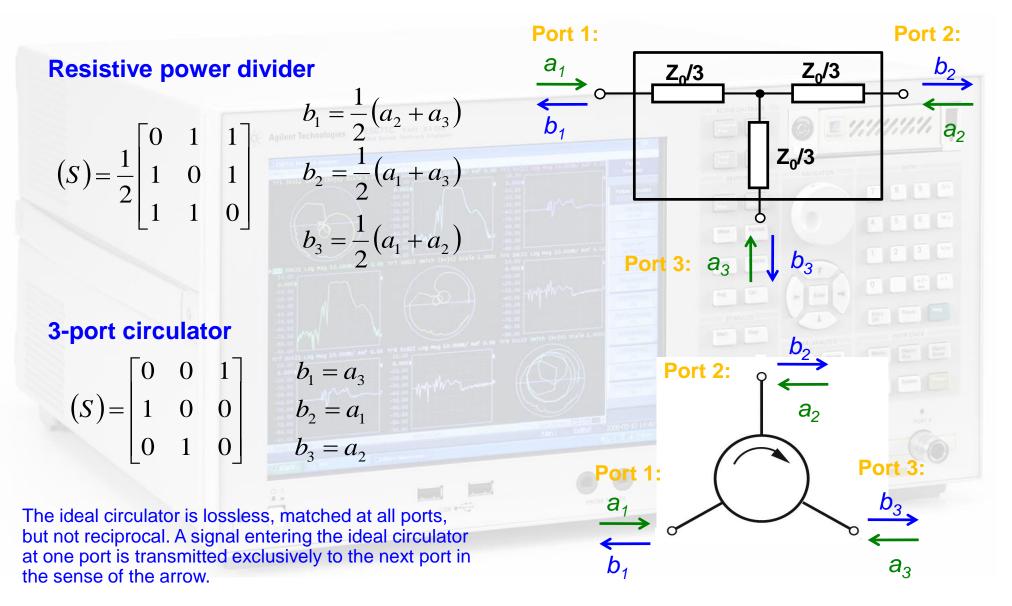
Pathing through a 2-port (1)



Pathing through a 2-port (2)



Examples of 3-ports (1)



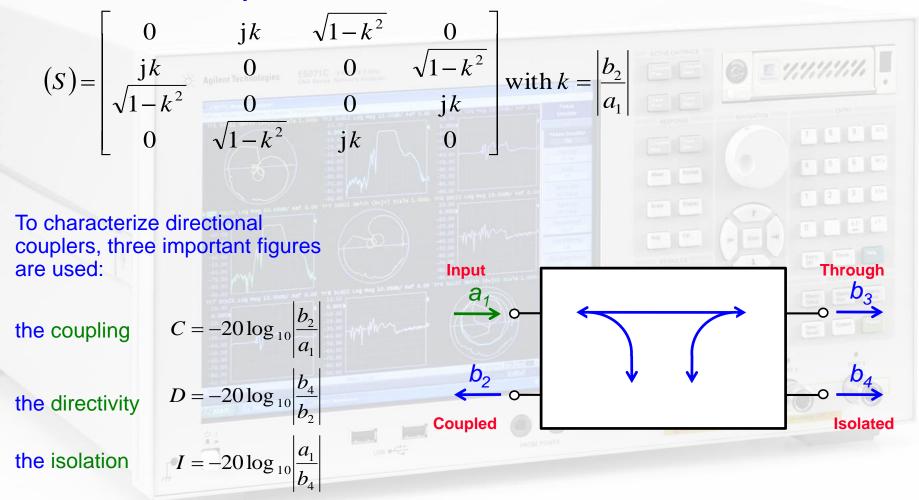
Examples of 3-ports (2)

Practical implementations of circulators: Port 3 н B Port 1 **Stripline circulator** Port 2 Ferrite Port 3 Waveguide circulator ground plates Port ² ferrite disc

A circulator contains a volume of ferrite. The magnetically polarized ferrite provides the required non-reciprocal properties, thus power is only transmitted from port 1 to port 2, from port 2 to port 3, and from port 3 to port 1.

Examples of 4-ports (1)

Ideal directional coupler



Appendix C: T matrix

The T-parameter matrix is related to the incident and reflected normalised waves at each of the ports.

$$\begin{pmatrix} b_1 \\ a_1 \end{pmatrix} = \begin{bmatrix} T_{11} & T_{12} \\ T_{21} & T_{22} \end{bmatrix} \begin{pmatrix} a_2 \\ b_2 \end{pmatrix}$$

T-parameters may be used to determine the effect of a cascaded 2-port networks by simply multiplying the individual T-parameter matrices:
$$[T] = [T^{(1)}][T^{(2)}] \dots [T^{(N)}] = \prod_{N} [T^{(i)}] \qquad \bigoplus_{a_1} \underbrace{T^{(1)}}_{a_1} \underbrace{a_2}_{b_2} \underbrace{b_3}_{a_3} \underbrace{T^{(2)}}_{b_4} \underbrace{a_4}_{b_4}$$

T-parameters can be directly evaluated from the associated S-

From T to S:

parameters and vice versa.

From S to T:

$$[T] = \frac{1}{S_{21}} \begin{bmatrix} -\det(S) & S_{11} \\ -S_{22} & 1 \end{bmatrix} \qquad [S] = \frac{1}{T_{22}} \begin{bmatrix} T_{12} & \det(T) \\ 1 & -T_{21} \end{bmatrix}$$

Appendix D: A Step in Characteristic Impedance (1)

Consider a connection of two coaxial cables, one with $Z_{C,1} = 50 \Omega$ characteristic impedance, the other with $Z_{C,2} = 75 \Omega$ characteristic impedance.

 $\begin{array}{c} 1 \\ \bigcirc \\ O \\ Z_{C,1} = 50\Omega \end{array} \begin{array}{c} \text{Connection between a} \\ 50 \ \Omega \text{ and a 75 } \Omega \text{ cable.} \\ \text{We assume an infinitely} \\ \text{short cable length and} \\ \text{just look at the junction.} \end{array} \begin{array}{c} 2 \\ \bigcirc \\ O \\ Z_{C,2} = 75\Omega \end{array} \begin{array}{c} a_i \\ \bigcirc \\ b_i \end{array} \begin{array}{c} Z_{C,1} \\ \frown \\ b_i \end{array} \begin{array}{c} Z_{C,2} \\ \frown \\ b_i \end{array} \begin{array}{c} Z_{C,2} \\ \frown \\ b_i \end{array} \begin{array}{c} Z_{C,2} \\ \bullet \\ b_i \end{array} \end{array}$

Step 1: Calculate the reflection coefficient and keep in mind: all ports have to be terminated with their respective characteristic impedance, i.e. 75 Ω for port 2.

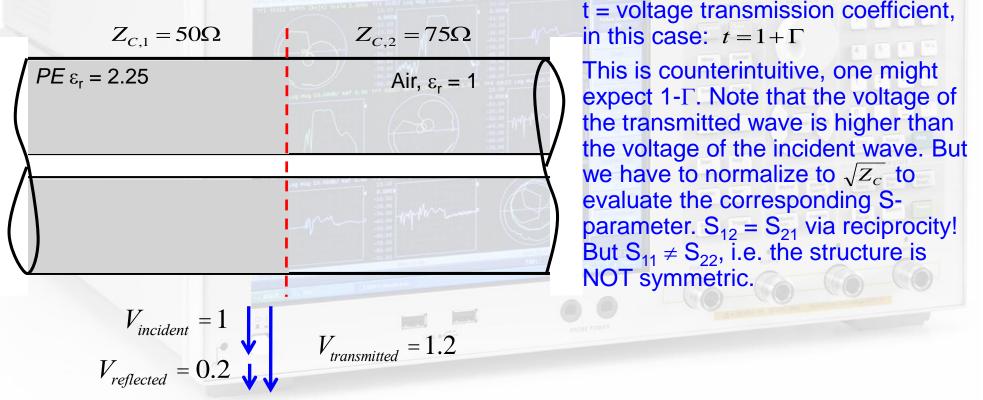
$$\Gamma_1 = \frac{Z - Z_{C,1}}{Z + Z_{C,1}} = \frac{75 - 50}{75 + 50} = 0.2$$

Thus, the voltage of the reflected wave at port 1 is 20% of the incident wave, and the reflected power at port 1 (proportional Γ^2) is $0.2^2 = 4\%$. As this junction is lossless, the transmitted power must be 96% (conservation of energy). From this we can deduce $b_2^2 = 0.96$. But: how do we get the voltage of this outgoing wave?

Example: a Step in Characteristic Impedance (2)

<u>Step 2</u>: Remember, *a* and *b* are **power-waves**, and defined as voltage of the forward- or backward traveling wave normalized to $\sqrt{Z_c}$.

The tangential electric field in the dielectric in the 50 Ω and the 75 Ω line, respectively, must be continuous.



Example: a Step in Characteristic Impedance (3)

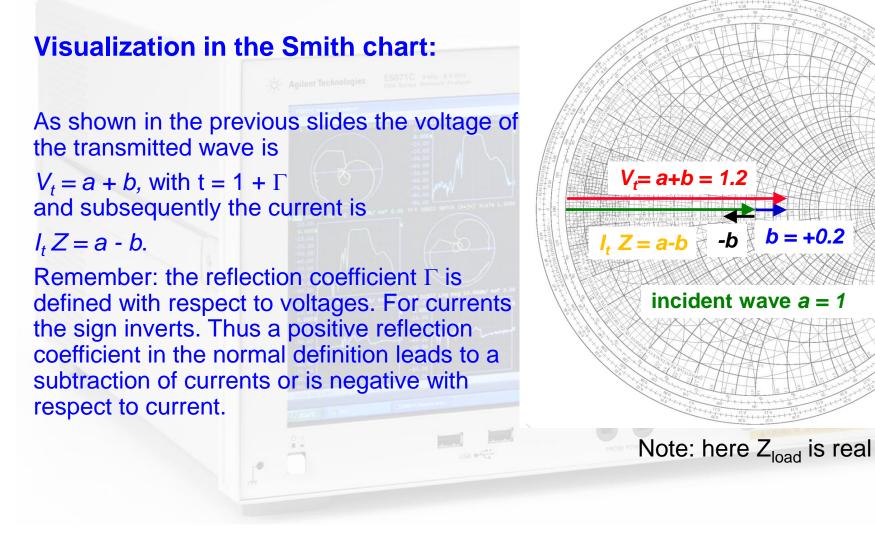
Once we have determined the voltage transmission coefficient, we have to normalize to the ratio of the characteristic impedances, respectively. Thus we get for

$$S_{12} = 1.2\sqrt{\frac{50}{75}} = 1.2 \cdot 0.816 = 0.9798$$

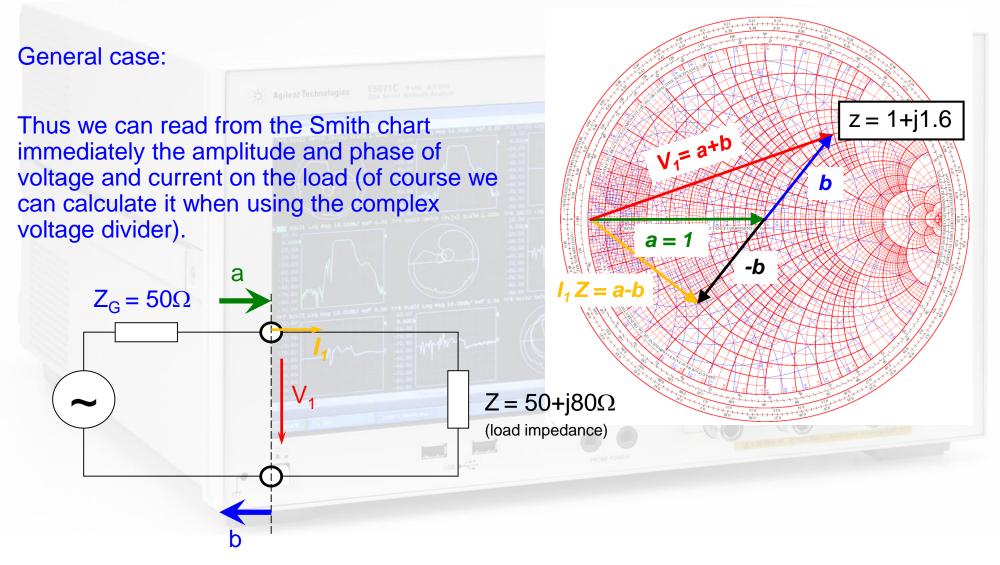
We know from the previous calculation that the reflected <u>power</u> (proportional Γ^2) is 4% of the incident power. Thus 96% of the power are transmitted. Check done $S_{12}^{2} = 1.44 \frac{1}{1.5} = 0.96 = (0.9798)^{2}$

$$S_{22} = \frac{50 - 75}{50 + 75} = -0.2$$
 To be compared with S11 = +0.2!

Example: a Step in Characteristic Impedance (4)



Example: a Step in Characteristic Impedance (5)



Appendix E: Navigation in the Smith Chart (1)

points

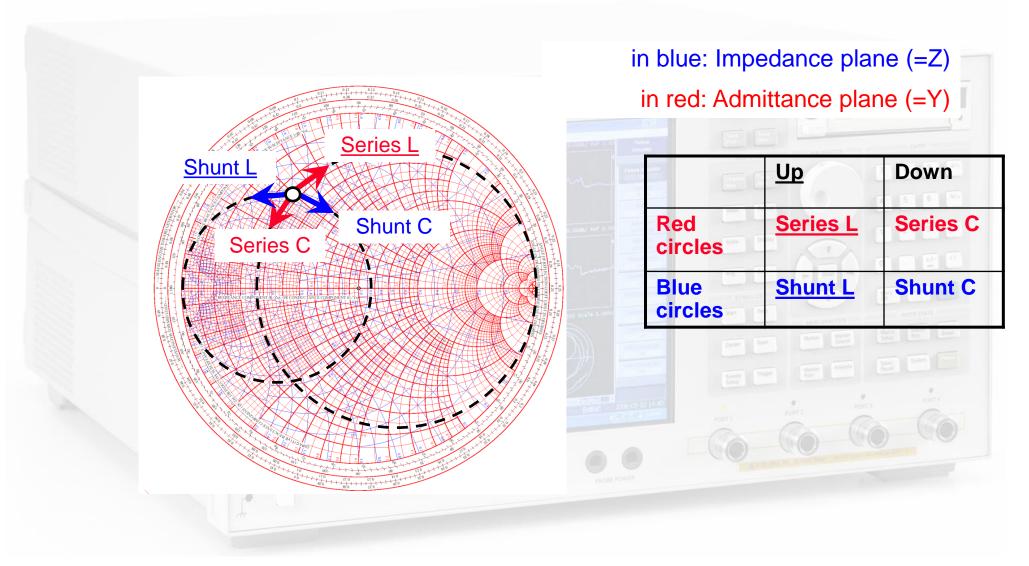
This is a "bilinear" transformation with the following properties:

- generalized circles are transformed into generalized circles
 - circle \rightarrow circle
 - straight line \rightarrow circle
 - circle → straight line
 - straight line → straight line
- angles are preserved locally

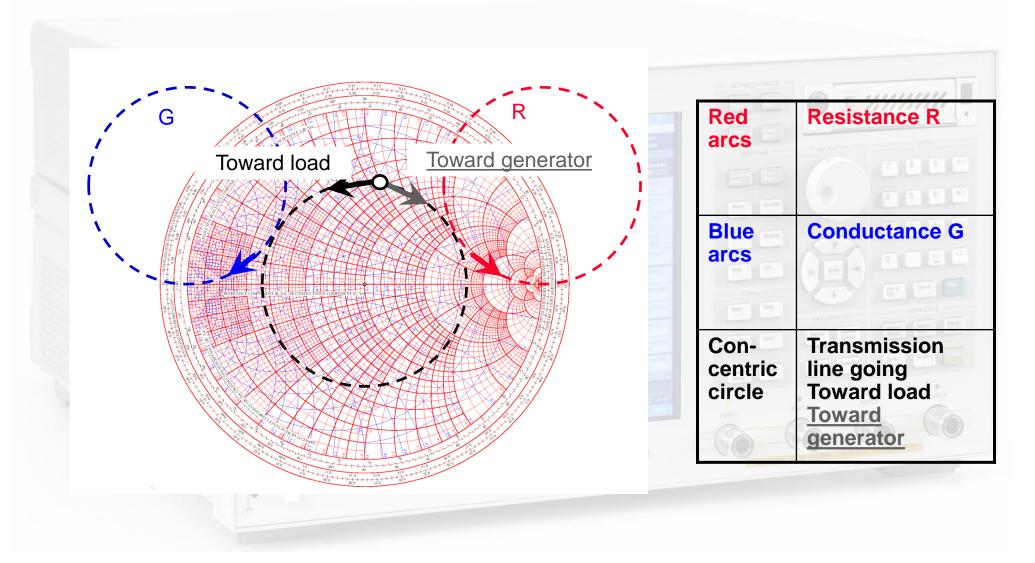
a circle with infinite radius a circle is defined by 3 points a straight line is defined by 2

a straight line is nothing else than

Navigation in the Smith Chart (2)



Navigation in the Smith Chart (3)



Appendix F: The RF diode (1)

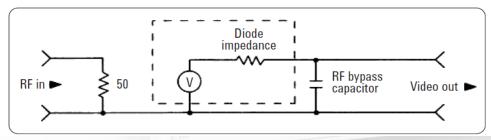
- We are not discussing the generation of RF signals here, just the detection
- Basic tool: fast RF* diode

 (= Schottky diode)

 In general, Schottky diodes are

 fast but still have a voltage
 dependent junction capacity
 (metal semi-conductor junction)

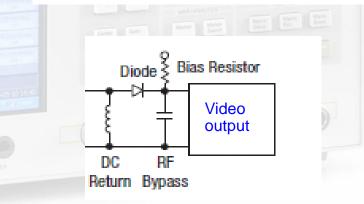
Equivalent circuit:





A typical RF detector diode

Try to guess from the type of the connector which side is the RF input and which is the output

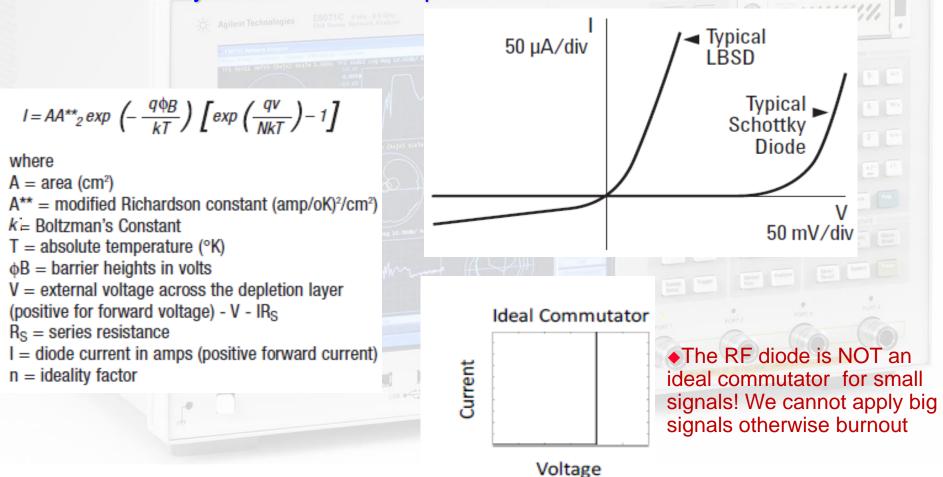


*Please note, in this lecture we will use RF (radio-frequency) for both, the RF and the microwave range, since there is no defined borderline between the RF and microwave regime.

The RF diode (2)

Characteristics of a diode:

The current as a function of the voltage for a barrier diode can be described by the Richardson equation:

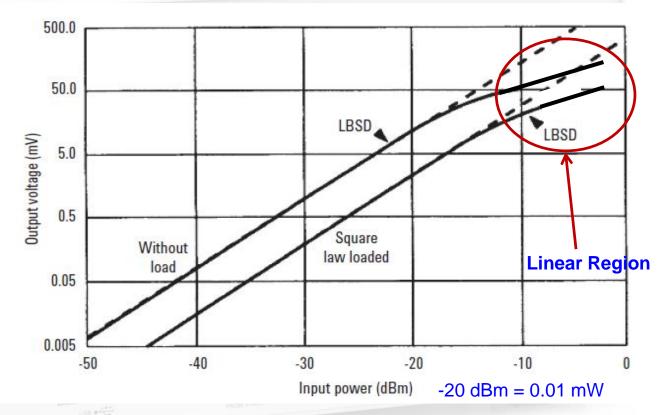


The RF diode (3)

This diagram depicts the so called square-law region where the output voltage (V_{Video}) is proportional to the input power

Since the input power is proportional to the square of the input voltage (V_{RF}^2) and the output signal is proportional to the input power, this region is called square- law region.

In other words: $V_{Video} \sim V_{RF}^2$



 The transition between the linear region and the square-law region is typically between -10 and -20 dBm RF power (see diagram).

The RF diode (5)

Due to the square-law characteristic we arrive at the thermal noise region already for moderate power levels (-50 to -60 dBm) and hence the V_{Video} disappears in the thermal noise

This is described by the term tangential signal sensitivity (TSS) where the detected signal (Observation BW, usually 10 MHz) is 4 dB over the thermal noise floor

Appendix G: The RF mixer (1)

- For the detection of very small RF signals we prefer a device that has a linear response over the full range (from 0 dBm (= 1mW) down to thermal noise = -174 dBm/Hz = 4.10⁻²¹ W/Hz)
 - It is called "RF mixer", and uses 1, 2 or 4 diodes in different configurations (see next slide)
- Together with a so called LO (local oscillator) signal, the mixer works as a signal multiplier, providing a very high dynamic range since the output signal is always in the "linear range", assuming the mixer is not in saturation with respect to the RF input signal (For the LO signal the mixer should always be in saturation!)
- The RF mixer is essentially a multiplier implementing the function

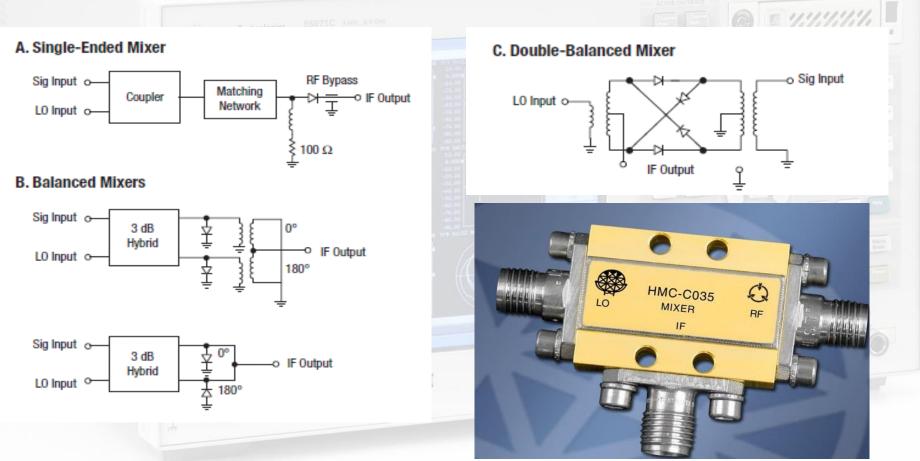
 $f_1(t) \cdot f_2(t)$ with $f_1(t) = RF$ signal and $f_2(t) = LO$ signal

 $a_1 \cos(2\pi f_1 t + \varphi) \cdot a_2 \cos(2\pi f_2 t) = \frac{1}{2} a_1 a_2 [\cos((f_1 + f_2)t + \varphi) + \cos((f_1 - f_2)t + \varphi)]$

Thus we obtain a response at the IF (intermediate frequency) port as sum and difference frequencies of the LO and RF signals

The RF mixer (2)

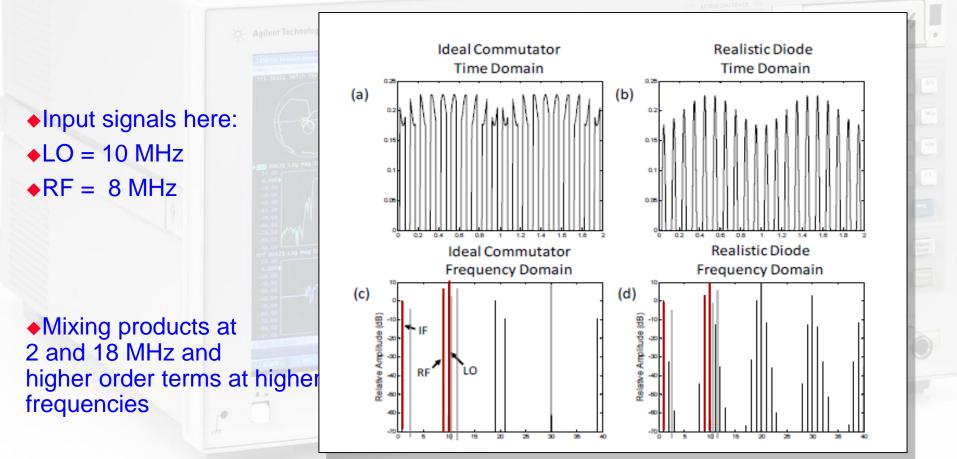
Examples of different mixer configurations



A typical coaxial mixer (SMA connector)

The RF mixer (3)

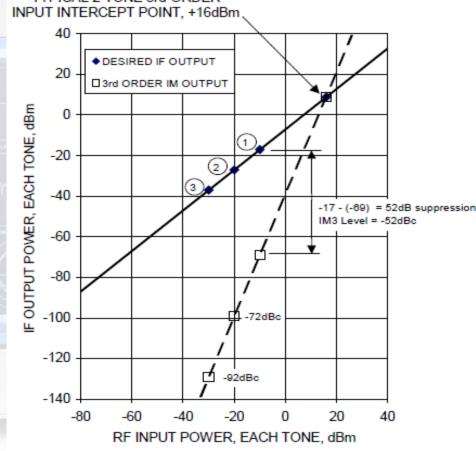
Response of a mixer in time and frequency domain:



The RF mixer (4)

Dynamic range and IP3 of an RF mixer

- The abbreviation IP3 stands for third order intermodulation point, where the two lines shown in the right diagram intersect. Two signals $(f_1, f_2 > f_1)$ which are closely spaced by Δf in frequency are simultaneously applied to the DUT. The intermodulation products appear at + Δf above f_2 and at – Δf below f_1 .
- This intersection point is usually not measured directly, but extrapolated from measurement data at much lower power levels to avoid overload and/or damage of the DUT.



TYPICAL 2-TONE 3rd-ORDER